TEW 2877

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Thre the Application of: Takashi FUJITA et al.

Group Art Unit: 2877

2006ASplication Number: 10/561,538

Examiner:

led: December 19, 2005

Confirmation Number: 9367

For:

SPECIFIC COMPONENT MEASURING METHOD BY SPECTRAL

MEASUREMENT

Attorney Docket Number:

053362

Customer Number:

38834

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P. O. Box 1450 Alexandria, VA 22313-1450 July 7, 2006

Sir:

Applicants direct the attention of the Patent and Trademark Office to the documents listed on the attached PTO/SB/08. This paper is being filed within the time periods set forth in 37 C.F.R. §1.97(b). A copy of each non-U.S. document is enclosed herewith.

If there are any fees due in connection with the filing of this paper, please charge Deposit Account No. 50-2866.

Respectfully submitted,

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Enclosures: PTO/SB/08

Form PCT/IB/338 Form PCT/IB/373 Form PCT/ISA/237

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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of

Compl	ete if Known
Application Number	10/561,538
Confirmation Number	9367
Filing Date	December 19, 2005
First Named Inventor	Takashi FUJITA et al.
Art Unit	2877
Examiner Name	
Attorney Docket Number	053362

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No.1	Document Number		Publication Date	•
		Number	Kind Code ² (if known)	MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		US			
		US			
		US			
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		US			
		US			

FOREIGN PATENT DOCUMENTS							
Examiner Initials*	Cite No.1	Foreign Patent Document			Publication Date	Name of Patentee or	
		Country Code ³	Number ⁴	Kind Code ⁵ (if known)	MM-DD-YYYY	Applicant of Cited Document	Translation ⁶
				<u> </u>			

NON PATENT LITERATURE DOCUMENTS							
	Cite No.1						
	1	Notification of Transmittal of Copies of Translation of the International Preliminary Report on Patentability (Form PCT/IB/338) of International Application No. PCT/JP2004/008711 mailed June 1, 2006 with Forms PCT/IB/373 and PCT/ISA/237					

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Examiner Signature	 Date Considered	

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Applicant's unique citation designation number (optional). ²See Kind Codes of USPTO Patent Documents at www.uspto.gov, MPEP 901.04 or in the comment box of this document. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST. 3). ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to indicate here if English language Translation is attached.